

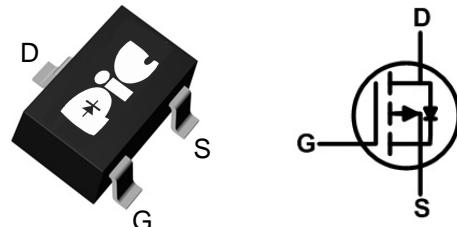
➤ General Description

This PAP3117NS P-Channel enhancement mode power field effect transistor is the high density trench technology and this advanced technology can provide excellent Rds(On) performance and efficiency for power switching and load switching application., this device also comply with the RoHS and Green Product requirement with full function reliability approved.

➤ Feature

- Green Device Available
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Advanced high cell density Trench technology
- SOT-23S package design

➤ SOT-23S



➤ Application

- Load Switch
- Portable instrument
- MB / NB / 3C device

➤ Absolute Maximum Ratings

Parameter	Symbol	Rating		Units
		10s	Steady State	
Drain-Source Voltage	V _{DS}	-30		V
Gate-Source Voltage	V _{GS}	±20		V
Continuous Drain Current, V _{GS} @ -10V ¹	I _D @T _A =25°C	-3.6	-3.2	A
Continuous Drain Current, V _{GS} @ -10V ¹	I _D @T _A =70°C	-2.9	-2.5	A
Pulsed Drain Current ²	I _{DM}	-13		A
Total Power Dissipation ³	P _D @T _A =25°C	1.32	1	W
Total Power Dissipation ³	P _D @T _A =70°C	0.84	0.64	W
Storage Temperature Range	T _{STG}	-55 to 150		°C
Operating Junction Temperature Range	T _J	-55 to 150		°C
Thermal Resistance Junction-ambient ¹	R _{θJA}	125		°C/W
Thermal Resistance Junction-Ambient ¹ (t ≤10s)	R _{θJA}	95		°C/W
Thermal Resistance Junction-Case ¹	R _{θJC}	80		°C/W

➤ **Electrical Characteristics (T_J=25°C Unless otherwise noted)**

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =-250μA	-30	---	---	V
BVDSS Temperature Coefficient	△BV _{DSS} /△T _J	Reference to 25°C, I _D =-1mA	---	-0.02	---	V/°C
Static Drain-Source On-Resistance ²	R _{DS(ON)}	V _{GS} =-10V, I _D =-3A	---	55	70	mΩ
		V _{GS} =-4.5V, I _D =-1.5A	---	90	120	
Gate Threshold Voltage	V _{GS(th)}	V _{GS} =V _{DS} , I _D =-250μA	-1.2	-1.5	-2.5	V
V _{GS(th)} Temperature Coefficient	△V _{GS(th)}		---	4.32	---	mV/°C
Drain-Source Leakage Current	I _{DSS}	V _{DS} =-24V, V _{GS} =0V, T _J =25°C	---	---	-1	uA
		V _{DS} =-24V, V _{GS} =0V, T _J =55°C	---	---	-5	
Gate-Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V	---	---	±100	nA
Forward Transconductance	g _{fs}	V _{DS} =-5V, I _D =-3A	---	4.8	---	S
Gate Resistance	R _g	V _{DS} =0V, V _{GS} =0V, f=1MHz	---	24	48	Ω
Total Gate Charge (-4.5V)	Q _g	V _{DS} =-20V, V _{GS} =-4.5V, I _D =-3A	---	5.22	7.3	nC
Gate-Source Charge	Q _{gs}		---	1.25	1.8	
Gate-Drain Charge	Q _{gd}		---	2.3	3.2	
Turn-On Delay Time	T _{d(on)}	V _{DD} =-15V, V _{GS} =-10V, R _G =3.3Ω I _D =-1A	---	18.4	37	ns
Rise Time	T _r		---	11.4	21	
Turn-Off Delay Time	T _{d(off)}		---	39.4	79	
Fall Time	T _f		---	5.2	10.4	
Input Capacitance	C _{iss}	V _{DS} =-15V, V _{GS} =0V, f=1MHz	---	463	650	pF
Output Capacitance	C _{oss}		---	82	115	
Reverse Transfer Capacitance	C _{rss}		---	68	95	

➤ **Diode Characteristics**

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Continuous Source Current ^{1,4}	I _S	V _G =V _D =0V, Force Current	---	---	-3.2	A
Pulsed Source Current ^{2,4}	I _{SM}		---	---	-13	A
Diode Forward Voltage ²	V _{SD}	V _{GS} =0V, I _S =-1A, T _J =25°C	---	---	-1	V

Note :

- 1.Pulse width limited by maximum junction temperature.
- 2.The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%
- 3.Ensure that the channel temperature does not exceed 150°C.
- 4.The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.

➤ Typical Characteristics

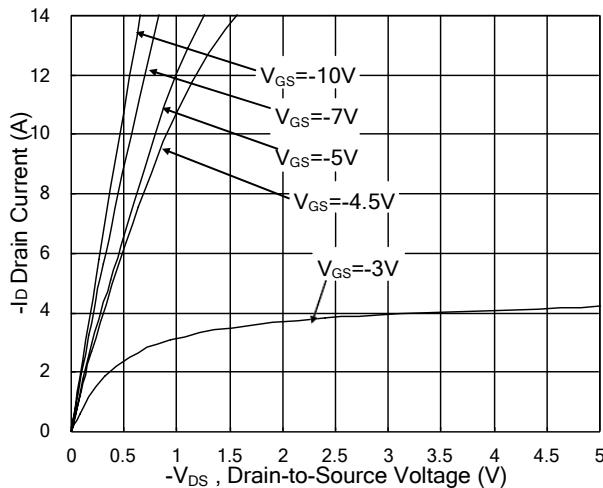


Fig.1 Typical Output Characteristics

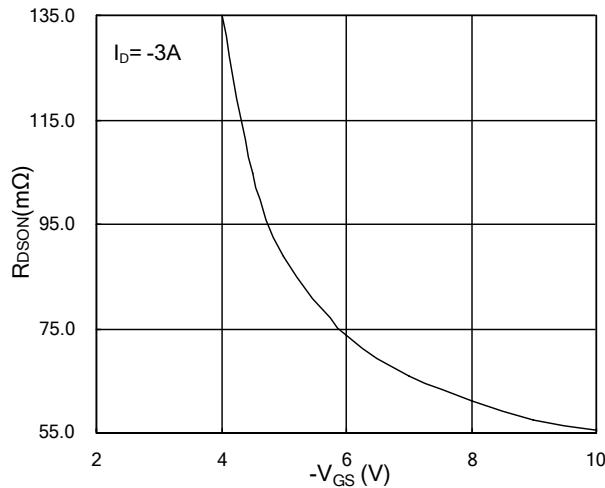


Fig.2 On-Resistance vs. G-S Voltage

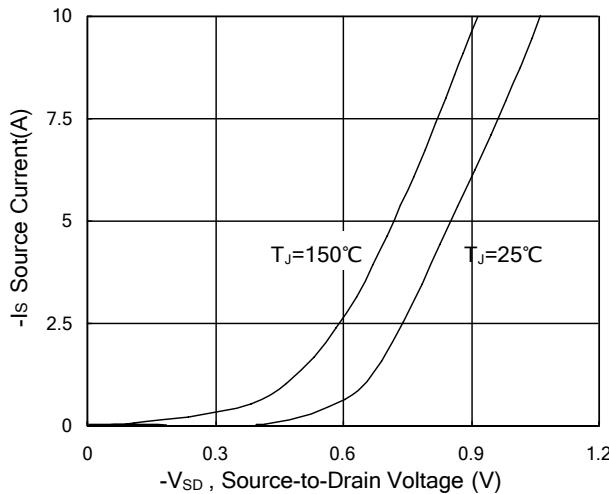


Fig.3 Source Drain Forward Characteristics

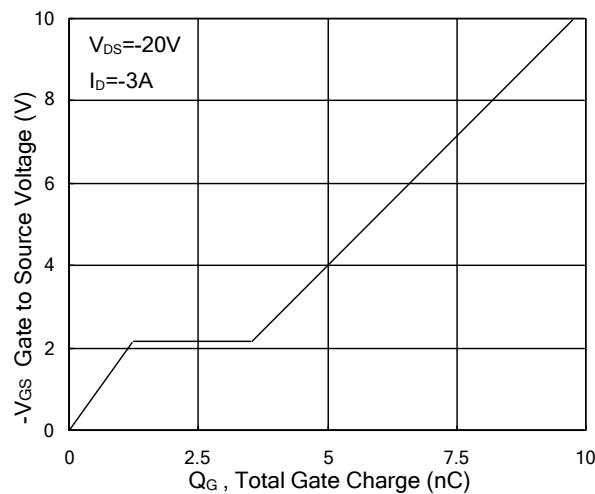


Fig.4 Gate-Charge Characteristics

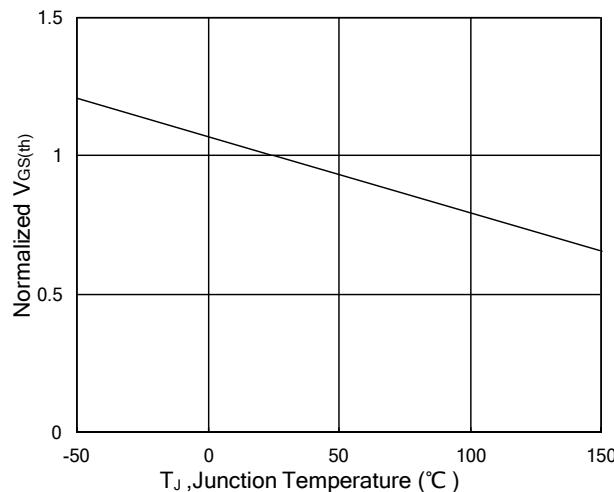


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

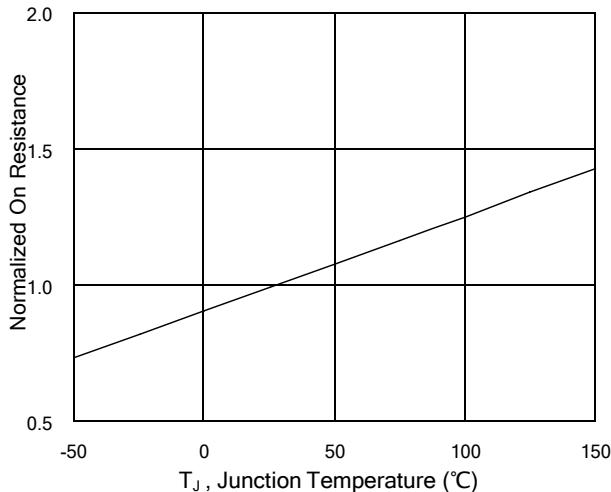
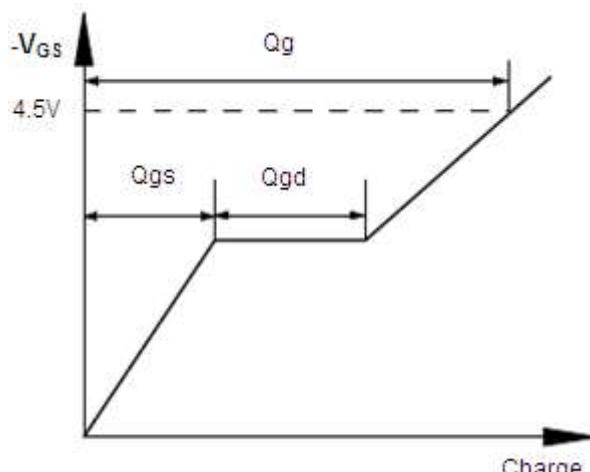
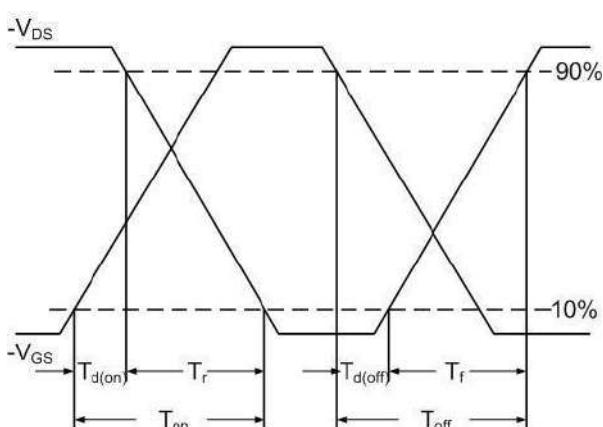
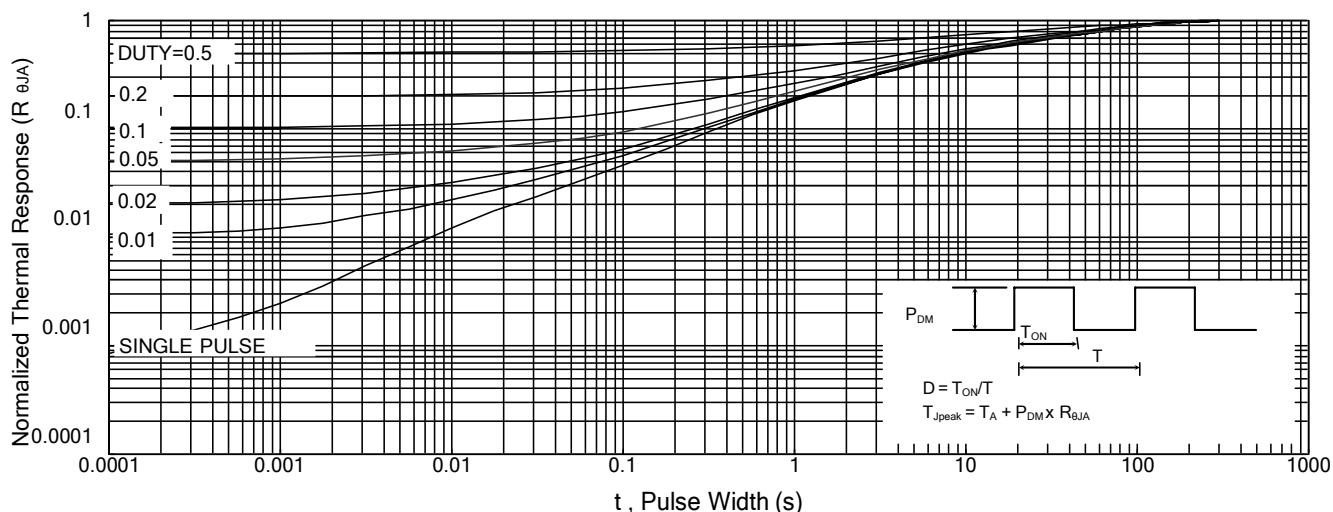
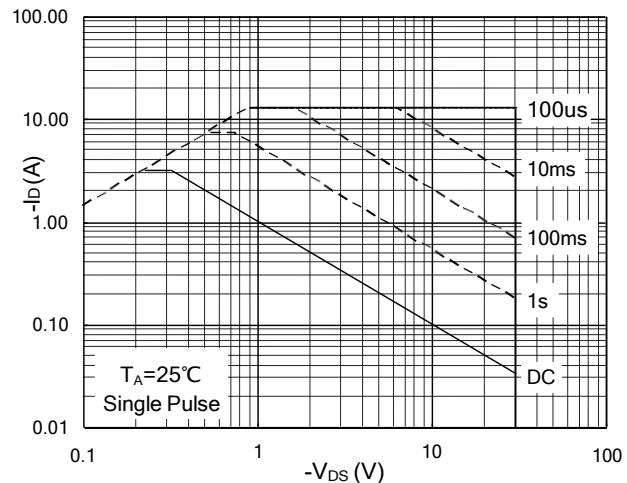
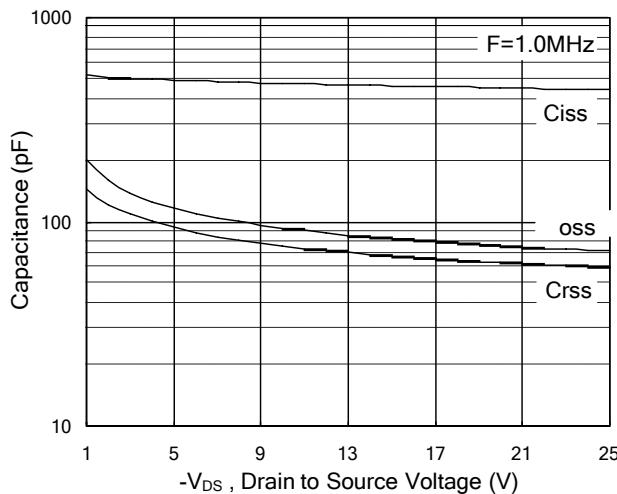
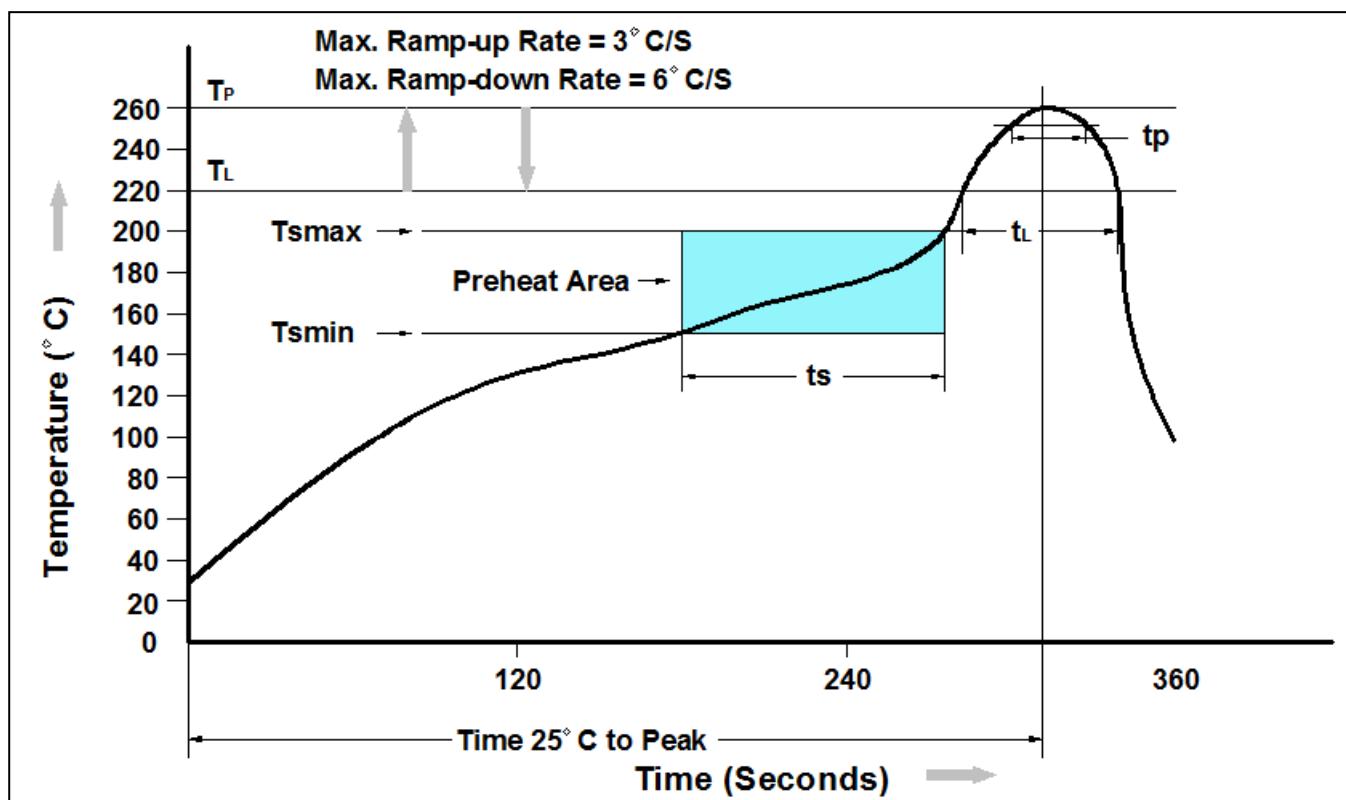


Fig.6 Normalized $R_{DS(on)}$ vs. T_J



➤ Recommand IR Reflow Soldering Thermal Profile

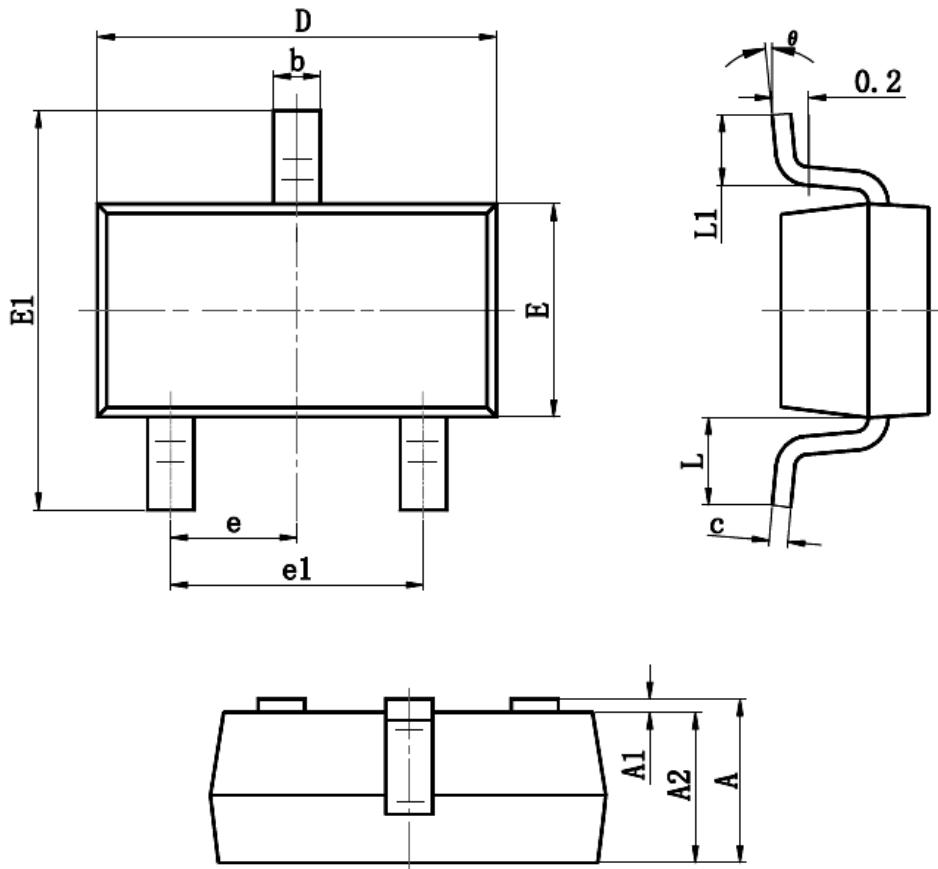


Profile Feature	Pb-Free Assembly Profile
Temperature Min. (T _{smin})	150°C
Temperature Max. (T _{smax})	200°C
Time (t _s) from (T _{smin} to T _{smax})	60-120 seconds
Average Ramp-up Rate (t _L to t _P)	3°C/second max.
Liquidous Temperature (T _L)	217°C
Time (t _L) Maintained Above (T _L)	60 – 150 seconds
Peak Temperature	260°C +0°C / -5°C
Time (t _P) within 5°C of actual Peak Temperature	30 seconds
Ramp-down Rate (T _P to T _L)	6°C/second max
Time 25°C to Peak Temperature	8 minutes max.

➤ Ordering Information

Part Number	Description	Quantity
PAP3117NS	SOT-23S Reel	3000 pcs

➤ **Package Information (SOT-23)**



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	0.900	1.200	0.035	0.043
A1	0.000	0.100	0.000	0.004
A2	0.900	1.100	0.035	0.039
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
e	0.950 TYP		0.037 TYP	
e1	1.800	2.000	0.071	0.079
L	0.550 REF		0.022 REF	
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	6°

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